relaxation time τ_c is related to the drift mobility by^{10,11}

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$$\tau_{c} = \int_{0}^{\infty} \tau \epsilon^{3/2} f^{0} d\epsilon \bigg/ \int_{0}^{\infty} \epsilon^{3/2} f^{0} d\epsilon$$
$$= \mu_{d} / \frac{1}{3} e \bigg(\frac{1}{m_{1}^{*}} + \frac{1}{m_{2}^{*}} + \frac{1}{m_{3}^{*}} \bigg).$$
(D1)

Similarly, the Hall relaxation time τ_H is related to the Hall mobility $\mu_H (= R\sigma_0)$ by

$$\tau_{H} = \int_{0}^{\infty} \tau^{2} \epsilon^{3/2} f^{0} d\epsilon \Big/ \int_{0}^{\infty} \tau \epsilon^{3/2} f^{0} d\epsilon$$

$$= \frac{\mu_{H}}{e} \Big(\frac{1}{m_{1}^{*}} + \frac{1}{m_{2}^{*}} + \frac{1}{m_{3}^{*}} \Big) \Big/ \Big(\frac{1}{m_{1}^{*} m_{2}^{*}} + \frac{1}{m_{2}^{*} m_{3}^{*}} + \frac{1}{m_{1}^{*} m_{2}^{*}} \Big). \quad (D2)$$

¹⁰ C. Herring, Bell System Tech. J. 34, 237 (1955); C. Herring and E. Vogt, Phys. Rev. 101, 944 (1956).
 ¹¹ J. C. Hensel, Phys. Rev. 129, 1041 (1963).

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Hall Mobility in SrTiO₃[†]

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Electron mobilities in reduced and doped SrTiO₂ have been deduced from measurements of the conductivity and Hall coefficient between 1 and 1000°K. Above room temperature, scattering by the highest two longitudinal optical modes determines the mobility. Expressions based on intermediate electron-phonon coupling yield good agreement with experimental results. Below 10°K experiments indicate that ionized impurity scattering is the dominant collision process. Using a screened Coulomb potential, one obtains mobility values of the right order of magnitude.

INTRODUCTION

'HE quantitative understanding of electron scat-L tering¹ in polar semiconductors has progressed somewhat less than that of scattering in covalent semiconductors.² This lag is caused by a number of inherent difficulties. At high temperatures, the mobility of electrons in polar semiconductors is often limited by optical mode scattering, which is governed by an electronphonon coupling constant α .^{3,4} The parameters that appear in α are the effective mass of the electron m^* , the energy of the phonon $\hbar\omega_{\rm ph}$, and the high- and low-frequency dielectric constants of the medium, ϵ_{op} and ϵ_{stat} . So far, very little has been done theoretically to take into account the energy and wave-vector dependence of these quantities. Moreover, the electrons in a polar material have an effective mass different from that calculated on the basis of a rigid lattice. In a polar crystal an electron will cause a local polarization, which will "dress" the electron. Hence the electron- when moving-will take this "polarization-dressing" along. The

If we now re-examine our formalism, we note that in the nondegenerate limit, H_{2i} of Eq. (2.21) is proportional to

$$\int_0^\infty \epsilon_i^{3/2} f_i^0 d\epsilon_i.$$

Thus, our τ should be defined as

 $\tau^2 = \tau_c \tau_H = \frac{3\mu_H \mu_d}{e^2} /$

$$\tau^{2} \equiv \int_{0}^{\infty} \tau^{2} \epsilon_{i}^{3/2} f_{i}^{0} d\epsilon_{i} \bigg/ \int_{0}^{\infty} \epsilon_{i}^{3/2} f_{i}^{0} d\epsilon_{i} \qquad (D3)$$

 $\left(\frac{1}{m_1^*m_2^*} + \frac{1}{m_2^*m_3^*} + \frac{1}{m_1^*m_2^*}\right).$ (D4)

which can also be obtained from (D1) and (D2) by

 $[\]dagger$ Research supported in part by the National Aeronautics and Space Administration.

¹It is noteworthy that the *Proceedings of the International Con-ference on the Physics of Semiconductors, Kyoto, 1966* [J. Phys. Soc. Japan Suppl. 21 (1966)] do not contain a single paper (ex-perimental or theoretical) dealing with phonon- or impuritylimited Hall mobilities in semiconductors. ² F. J. Blatt, Solid State Phys. 4, 199 (1957).

^{*} H. Fröhlich and N. F. Mott, Proc. Roy. Soc. (London) A171, 496 (1939).

⁴ F. E. Low and D. Pines, Phys. Rev. 98, 414 (1955).

electron becomes a "polaron" and the effective mass of this quasiparticle is larger.⁵

There are also difficulties of an experimental nature. Plotting the Hall mobility of several polar semiconductors as a function of temperature over a limited temperature range, many experimenters find it difficult to decide between an exponential behavior and a power law.6 If the energy of the phonon involved is of the order of 30-70 meV, a plot of log μ versus 1/T produces as good (or bad) a straight line as $\log \mu$ versus $\log T$ (over a range of T around room temperature). In the latter case the power of T is usually between -2.5 and -3.2. Such a temperature dependence has been observed in covalent, many-valley semiconductors and is attributed to inter-valley scattering involving acoustical modes.⁷

The low-temperature mobility usually is limited by defect scattering, the defects being ionized or neutral impurities, dislocations, grain boundaries, or possibly magnetic ions. To determine the specific nature of the scattering mechanism, one studies the temperature dependence and magnitude of the mobility and compares these with theoretical predictions.² The main physical parameters governing the scattering are the electron effective mass and the dielectric constant; however, these quantities are significantly modified as a result of the screening by the electrons themselves and by the host lattice. Comparison of theory with experiment often is hampered by the same kind of difficulties as one encounters at high temperatures. Uncertainties exist with respect to the choices of dielectric constant $(\epsilon_{op} \text{ or } \epsilon_{stat} \text{ or some value in between})$, effective mass (bare mass or polaron mass), screening length, cutoff distance, Fermi velocity (in case of anisotropic energy bands), etc.

The subject of this paper-electron mobility in reduced and doped SrTiO₃—illustrates the above problems very well. Some years ago, the present authors published data on transport properties in SrTiO₃ between 4.2 and 300°K.8 At that time we reached the conclusion that "in the temperature range 100-300°K the mobility is proportional to T^{-x} , where x is between 2.7 and 3.2." It was suggested that this power of T is compatible with acoustical lattice scattering taking into account an apparent temperature dependence of the effective mass. The reader was warned, however, that "this reasoning should be regarded with reservations."

More recently a similar temperature dependence of electron mobility was reported by Wemple⁹ for KTaO₃ $(\mu \sim T^{-2.7})$. In a subsequent letter,¹⁰ Wemple *et al.*, use hydrostatic-pressure experiments as evidence that the electron scattering in LMO3-type semiconductors is caused by the long-wavelength, transverse-optical (TO), ferroelectric lattice mode.¹¹) This conclusion is difficult to accept for the following reasons:

1. It has been shown that the electron in SrTiO₃ couples strongly to the highest two LO modes. Coupling to a transverse mode usually is much weaker.¹²

2. I-V curves obtained in tunneling experiments showed a strong peak at the energy of the highest longitudinal optic (LO) mode and no TO modes.¹³

3. A recent study of electronic transport in BaTiO₃ around the Curie temperature indicates that the mobility becomes anisotropic but does not show any discontinuity at T_c as expected when ϵ_{stat} would play a major role.14

A short time ago Tufte and Chapman¹⁵ announced measurements on SrTiO₃ up to 550°K, from which they concluded that scattering at high temperatures was dominated by polar optical-lattice modes.

The present paper discusses the electron mobility in Nb-, La-doped, and reduced SrTiO₃ as deduced from experiments of resistivity and Hall effect between 1 and 1000°K.

Results indicate scattering by the two highest longitudinal-optical (LO) modes at high temperature and ionized impurity scattering at low temperatures.

EXPERIMENTAL

The Hall coefficient and the resistivity of more than 30 samples have been measured. Some of these specimens were Nb or La doped by addition of Nb₂O₅ or La_2O_3 during the growth process. Six samples of this group have been investigated up to 900 or 1000°C in air. The majority of the samples were reduced under a variety of conditions with respect to reducing agent (hydrogen, titanium powder), gas pressure and temperature. Table I gives preparative details and other characteristics of all the samples studied.

The Hall coefficient and the resistivity were determined using a conventional potentiometric method. For the high-temperature measurements, platinum leads were fused to the samples using a Ti-Cu "solder."

RESULTS AND DISCUSSION

Typical data of Hall coefficient and resistivity as a function of temperature from 4.2 to 1000°K are shown in Fig. 1. The Hall coefficient is approximately independent of temperature. In all samples the charge carriers become degenerate on cooling within this temperature

⁶ G. R. Allcock, Advan. Phys. 5, 412 (1956). ⁶ See, e.g., R. L. Petritz and W. W. Scanlon, Phys. Rev. 97, 1620 (1955).

 ⁷ C. Herring, Bell System Tech. J. 34, 237 (1955).
 ⁸ H. P. R. Frederikse, W. R. Thurber, and W. R. Hosler, Phys. Rev. 134, A442 (1964). ⁹ S. H. Wemple, Phys. Rev. 137, A1575 (1965).

¹⁰ S. H. Wemple, A. Jayaraman, and M. Di Domenico, Jr., Phys. Rev. Letters 17, 142 (1966).

¹¹ R. A. Cowley, Phys. Rev. 134, A981 (1964).
¹² F. Stern, Solid State Phys. 15, 299 (1963).
¹³ S. Shapiro, Phys. Rev. 140, A169 (1965).
¹⁴ C. N. Berglund and W. S. Baer, Phys. Rev. 157, 358 (1967). Receipt of a copy of this paper prior to publication is gratefully acknowledged.

¹⁵ O. N. Tufte and P. W. Chapman, Phys. Rev. 155, 796 (1967).

Sample		Reduction temp. (°C)	Time (h)	Dopant wt. % oxide to powder	Carrier conc. 4.2°K (cm ⁻³)	Mobility at 4.2°K (cm²/V sec)	Activ. energy of mobility (eV)	
	HR41	725	22		3.5 ×1017	13 000		
	HR39	700	9		7.3 ×1017	7520		
	HR11	704	23		7.1×10^{17}	6960		
	HR9	770	26		1.1 ×10 ¹⁸	4900		
	HR56	850	22		2.0×10^{18}	6000		
	HR48	875	21		2.3 ×10 ¹⁸	7290		
	HR35	725	20		1.7 ×1018	10 400		
	HR49(111)	860	24		5.2×10^{18}	4300		
	HR49 ⁽¹¹⁰⁾	860	24		4.5×10^{18}	2050		
	HR55	950	28		6.0×10^{18}	1470		
	HR22	900	42		1.0 ×1019	2300		
	HR6a	950	60		2.2×10^{19}	1040		
	HR51	1000	23		9.4 ×10 ¹⁸	1609		
	HR33	1150	46		6.3 ×10 ¹⁹	368		
	HR58	1200	5		7.4 ×1019	316		
	HR63	1250	3		1.25×10^{20}	185		
	HR61	1300	3		1.1×10^{20}	228		
	HR59	1370	2.5		5.3×10^{20}	67		
	Nb 5,16			0.05	7.4×10^{18}	7970	0.108	0.062
	Nb 7			0.05	5.7 ×10 ¹⁸	8880		
	Nb 8			0.07	1.3 ×10 ¹⁹	5330		
	Nb 9			0.15	1.8 ×10 ¹⁹	4510		
	Nb 10			0.50	1.7×10^{20}	613		
	Nb 11			1.0	3.8×10^{20}	206		
	Nb 12			0.10	1.6 ×1019	3250		
	Nb 15			0.01			0.101	0.057
	La 1, 2			0.1	1.6 ×10 ¹⁹	4115	0.121	0.057
	La 3			0.025	3.1×10^{18}		0.103	0.062

TABLE I. Characteristics of reduced and doped SrTiO₂ samples.

range. Consequently, the Hall coefficient contains a scattering factor unequal to 1.0 at high temperatures, while this factor is 1.0 in the degenerate range (e.g., 4.2° K). Hall coefficients at liquid-helium temperatures have been used to calculate the carrier concentration listed in column 5 of Table I.

A. High-Temperature Range (200-1000°K)

The mobility μ_H presented in Fig. 2 is plotted semilogarithmically. Over the temperature range shown here and down to 100°K, μ_H does not depend significantly on the impurity content, hence the scattering mechanism



FIG. 1. Electronic transport parameters of reduced (HR-11) and doped (Nb 5 and La 1) SrTiO₃. (Resistivity: solid lines; Hall coefficient: dashed lines.)

must be intrinsic. The data shown in Fig. 2 fall reasonably well on two straight lines. The slopes of these lines correspond to energies of the order of 0.10–0.12 eV and 0.057–0.62 eV (listed in Table I). These values are very close to the energies of the highest and second-highest longitudinal-optical modes, 0.099 eV and 0.058 eV, respectively.¹⁶ Hence, it is worthwhile to check the absolute value of the mobility with theoretical predictions. The optical-mode scattering depends on the electron-phonon coupling constant α . For the intermediate coupling range (1 $<\alpha < 6$), Low and Pines⁴ derived the following expression:

$$\mu_{\text{i.e.}} = \frac{1}{2\alpha\omega_l} \times \frac{e}{m_P} \left(\frac{m^*}{m_P}\right)^2 f(\alpha) \left(e^{\hbar\omega_l/kT} - 1\right), \qquad (1)$$

where:

k

$$m_P = \text{polaron mass} = m^*(1 + \alpha/6),$$
 (2)

and $m^* = (\text{bare})$ effective mass, $\omega_l = \text{frequency}$ of the long. opt. mode involved, and $f(\alpha) = a$ function which rises slowly from 1.0 to 1.4 when α increases from 1 to 6. Equation (1) has to be used twice, for the highest LO mode ($\hbar\omega = 0.099 \text{ eV}$) and for the next lower one ($\hbar\omega = 0.058$). The resulting mobilities μ_1 and μ_2 are then added reciprocally:

$$1/\mu = (1/\mu_1) + (1/\mu_2).$$
 (3)

For m^* in Eq. (1), we have chosen the "mobility-mass"

¹⁶ W. S. Spitzer et al., Phys. Rev. 126, 1710 (1962).

 $m^* = 2m_0$, a value found both by Barker¹⁷ and by Frederikse et al.18 The coupling constants-calculated by Eagles¹⁹—are now as follows:

LO₁-mode
$$\alpha_1 = 1.83 \ (m^*/m)^{1/2} = 2.6$$

LO₂-mode $\alpha_2 = 0.50 \ (m^*/m)^{1/2} = 0.7$.

The corresponding polaron mass is [Eq. (2)]:

$$m_P = 2.0 \left(1 + \frac{2.6 + 0.7}{6} \right) m_0 = 3.1 m_0.$$

The mobilities computed from Eq. (1) are plotted in Fig. 2. The agreement is reasonable; above room temperature, the theoretical values deviate at most 40-50%from the experimental data points.

Some of the values chosen for the parameters in Eq. (1) as well as the evaluation of μ are subject to question. One can argue that $m_{\rm eff} = 2m_0$ is the value of the polaron mass. Hence the real "bare" mass is about $1.5 m_0$ and the α 's are 10 to 20% smaller. This would increase the calculated mobilities slightly. However, the reasonable agreement with experimental data would not alter drastically. It is also legitimate to raise objections concerning the evaluation of μ_{tot} by adding μ_1 and μ_2 reciprocally. This procedure is a not completely justifiable extrapolation from the weak coupling range. However, considering that very little is known about the interaction of the two scattering processes (the LO₃ and the LO2 mode), and taking into account that the coupling constants are not too far removed from the perturbation range, the assumption of independent scattering by the two modes is not unreasonable.

B. Low-Temperature Range $(T < 10^{\circ} K)$

Table I lists values of the Hall mobilities of several doped and reduced samples at 4.2°K. These mobilities depend strongly on the impurity concentration N; the temperature dependence between 1 and 10°K is very small (see Fig. 1). Because all carriers are in the conduction band, and because the donors from which these carriers originate are the dominant impurities, N is related in a simple way to the charge-carrier concentration n. In the case of Nb and La doping, there is strong evidence that these ions substitute for Ti⁴⁺ and Sr²⁺, respectively.²⁰ Hence the donor charge is 1+. Recent publications suggest that the donor in reduced SrTiO₃ is an oxygen vacancy.²¹ The fact that the Hall coefficient does not change up to 1000°K would indi-

¹⁸ H. P. R. Frederikse, W. R. Thurber, W. R. Hosler, J. ¹⁹ D. M. Eagles, J. Phys. Chem. Solids 26, 672 (1965).
 ²⁰ Osamu Saburi, J. Phys. Coc. Japan 14, 1159 (1959).
 ²¹ A. E. Paladino, L. G. Rubin, and J. S. Waugh, J. Phys. Chem.



FIG. 2. Hall mobility of electrons in Sr FiO₂ above 200°K. The solid line represents calculated values using Eq. (1). Measured mobilities are labeled as follows: • La 2:0.1% La, \bigcirc La 3:0.025% La, \times Nb 5:0.05% Nb, \square Nb 15:0.01% Nb.

cate that these donors are already completely ionized at 1°K and that the charge is 2+.

The dependence of the mobility at 4.2°K on carrier concentration ($\sim Z$ times impurity concentration) is presented in Fig. 3. The data lie approximately on two straight lines (dashed): an upper one for doped specimens and a lower one (smaller by a factor 3.5-4.5) for reduced samples. Both lines show that $\mu \propto n^{-x}$, where $x=0.85\pm0.03$ for the doped specimens, and x=0.75 ± 0.03 for the reduced ones.

There are two extrinsic collision processes that depend on the concentration of impurities: neutral and ionized impurity scattering. The fact that for most of the samples investigated the number of (charged) donors



FIG. 3. Mobilities at 4.2°K of reduced and doped samples as a function of carrier concentration. The dashed lines are drawn as an average of the experimental values. The solid lines show the results of theoretical predictions [Eqs. (9), (10), and (11)].

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¹⁷ A. S. Barker, in *Proceedings of the International Colloquium on Optical Properties and Electronic Structure of Metals and Alloys, Paris, 1965* (North-Holland Publishing Company, Amsterdam, 1965)

Solids 26, 391 (1965).

introduced by doping or reduction is considerably larger than the concentration of existing (neutral) ions or imperfections removes the neutral impurity scattering as a major process. Ionized impurity scattering has been treated theoretically by Conwell and Weisskopf²² and by Brooks and Herring.23 The first two authors calculated the collision cross section in the Coulomb field on the basis of small scattering angles. The latter pair used a screened Coulomb potential and the Born approximation. Both assumptions can be described by the condition

$$ka\gg1$$
, (4)

where k = wave vector, and a = screening radius. At low temperatures, $k(=k_F)$ is of the order of several times 10^6 cm⁻¹, while a is about 3–10 Å (calculated for SrTiO₃) containing 7×10^{18} carriers/cm³; see below). Hence the product ka has values between 0.2 and 0.6 and the condition (4) is not valid. In other words, the electron energy is small compared with some measure of the scattering potential and the Born approximation is inapplicable.

The case $ka \ll 1$ has been investigated by several authors including Sclar,²⁴ Csavinsky,²⁵ and Gulyaev,²⁶ all using the partial-wave technique. In this paper we will follow the Gulvaev treatment.

To start with, one assumes that the electron "sees" an interaction potential

$$V(r) = \frac{Ze^2}{\epsilon} \frac{\exp(-r/a)}{r},$$
 (5)

where Ze =impurity charge, and $\epsilon =$ dielectric constant. The relaxation time of the collision process is given by

$$1/\tau = N_i v \sigma_T, \tag{6}$$

with N_i =number of scatterers, v=electron velocity $(=v_F, \frac{1}{2}mv_F^2 = E_F)$, and $\sigma_T = \text{total scattering cross sec-}$ tion. According to the partial-wave method, 25,26 if ka < <1, one can neglect all but the s-wave (l=0)phase shift and hence

$$\sigma_T = \frac{4\pi}{k^2} \sin^2 \delta_0 = \frac{4\pi}{k^2} \frac{1}{1 + \cot^2 \delta_0}.$$
 (7)

Using a variational principle, he derives the following formula: -2a2 1 20-1 22

$$\cot \delta_0 = -\frac{1}{4ka} \frac{\gamma^2 a^2 + 20\gamma a + 32}{\gamma^2 a^2 + 8\gamma a},$$
(8)

where

$$\gamma = \frac{2m_D^*}{\hbar^2} \times \frac{Ze^2}{\epsilon}$$

²² E. Conwell and V. F. Weisskopf, Phys. Rev. 77, 388 (1950). ²³ H. Brooks, Phys. Rev. 83, 879 (1951).
 ²⁴ N. Sclar, Phys. Rev. 104, 1548 (1956).

- 25 P. Csavinsky, Phys. Rev. 126, 1436 (1962); 131, 2033 (1963);
- 135, AB3 (1964). ²⁶ Yu V. Gulyaev, Fiz. Tver. Tela 1, 422 (1959) [English transl.: Soviet Phys.—Solid State 1, 381 (1959)].

and m_D = density-of-states effective mass = 5 m_0 . Hence,

$$\frac{1}{\tau} = 4\pi N_4 v_F a^2 \frac{16(\gamma^2 a^2 + 8\gamma a)}{(\gamma^2 a^2 + 20\gamma a + 32)},\tag{9}$$

from which one can easily calculate the mobility

$$\mu = e\tau/m_M^*, \tag{10}$$

where m_M^* = mobility-effective mass. Equations (9) and (10) show that the mobility is largely determined by the number of impurities, the velocity of the electrons and the screening length. The first two quantities are unambiguous. The main question remaining is what to use for the screening length a. One can choose the Fermi-Thomas expression²⁷

$$a_F = \left(\frac{\epsilon}{4\pi e^2 N(E_F)}\right)^{1/2} = \left[\frac{\hbar^2 \epsilon}{4m_D e^2} \left(\frac{\pi}{3n}\right)^{1/3}\right]^{1/2}, \quad (11)$$

where $N(E_F)$ = density of states at the Fermi level, and n = electron concentration. Or one might prefer the Bohm-Pines screening length²⁸

$$a_B = \left(\frac{\hbar\omega_P^*\epsilon}{4\pi ne^2}\right)^{1/2} = \left(\frac{\hbar^2\epsilon}{4\pi ne^2 m_M^*}\right)^{1/4},\qquad(12)$$

where $\omega_P^* =$ plasma frequency. Using a_F for a in Eq. (9), one finds $\mu \sim n^{-1.0} f(\gamma a)$, while substitution of a_B in the equation for μ leads to $\mu \sim n^{-0.83} f(\gamma a)$. The factor $f(\gamma a)$ contains the concentration n in such a way that it will decrease the power x in $\mu \sim n^{-x}$.

In order to obtain some perspective and to be able to judge the validity of the expressions (4) to (10), it is useful to calculate the values of some of the parameters for a particular value of n; $n=7\times10^{18}$ cm⁻³ (sample Nb 5). $E_F = 3.6 \times 10^{-15} \text{ erg} = 2.25 \text{ meV}, k_F = 6 \times 10^6 \text{ cm}^{-1}, v_F = 1.2 \times 10^6 \text{ cm/sec}, a = a_F = 2.3 \times 10^{-8} \text{ cm}, a_B = 9.4$ $\times 10^{-8}$ cm, $ka_F = 0.14$ or $ka_B = 0.57$, and $\gamma = 1.5 \times 10^{+8}$ cm⁻¹. Two other quantities are of importance:

(a) the polaron radius^{29,30}

$$r_P \approx \left(\frac{\hbar^2}{2m\hbar\omega_l}\right)^{1/2} = 4.5 \times 10^{-8} \text{ cm for } \hbar\omega_l = 0.099 \text{ eV}$$
$$= 5.9 \times 10^{-8} \text{ cm for } \hbar\omega_l = 0.058 \text{ eV}$$

and (b) the effective Bohr radius $a^* = 1.25 \times 10^{-8}$ cm. The values of m_D and ϵ used for the calculation of a_F were $5m_0$ and 5, respectively; the latter is the value of the optical dielectric constant. A similar assumption was made for the calculation of a_B ; however, in this case, m_M^* is the mobility mass $(=2m_0)$. The choice of $\epsilon=5$ seems to be appropriate in face of the calculated value

²⁷ E.g., C. Kittel, Quantum Theory of Solids (John Wiley & Sons, Inc., New York, 1963), p. 112.
²⁸ D. Bohm and D. Pines, Phys. Rev. 92, 609 (1953).
²⁹ H. Fröhlich, Advan. Phys. 3, 325 (1954).
³⁰ H. Haken in *Polarons and Excitons*, edited by C. G. Kuper and G. D. Whitfield (Plenum Press Inc., New York, 1963), p. 260. p. 269.

of the polaron radius; it means that at small distances from the impurity center the potential is rather large $(\sim 1/\epsilon_{opt})$, but that at 4–6 Å the static value (ϵ_{stat}) takes over, causing the potential to be negligible.³⁰ Hence, the value used for *a* in Eq. 9 must be smaller than r_p . This implies that the calculated value of a_F is probably all right, but that the figure for a_B is doubtful.

As a result of these considerations, the mobilities were computed using $a=a_F$. These values are shown as two solid lines in Fig. 3. The lower one, labeled Z=1, pertains to the Nb- and La-doped samples. It is clear that the theory underestimates the experimental mobilities by a factor of 2-3. The upper line is calculated for Z=2 and supposedly corresponds to the reduced samples (containing oxygen vacancies). Unfortunately the computed mobilities are somewhat higher than those for Z=1, contrary to expectations. However, one should realize that the shape and strength of the scattering potential does not enter in N_i , v, or a_F , but only in the "correction factor,"

$$f(\gamma a) = [16(\gamma^2 a^2 + 8\gamma a)/(\gamma^2 a^2 + 20\gamma a + 32)],$$

through the quantity γ . This correction factor does not depress the mobility enough to overcome the smaller number of scatterers when Z=2 ($N_i=\frac{1}{2}\times$ electron-concentration). In this case theory overestimates the experimental results 2–4 times.

The discrepancy of a factor of 2–4 between experimental and theoretical mobilities should not be taken too seriously. The choice of values for parameters like m^* and ϵ is very difficult because it is not always clear if one should use the density-of-states mass, the "mobility" mass, or perhaps the transverse mass. Furthermore, for regions of the order of several atomic cells, there is good reason not to substitute ϵ_{stat} for ϵ , but rather ϵ_{opt} . On the other hand, at very small distances from the impurity center, the concept of a dielectric constant becomes altogether inapplicable.

C. Intermediate-Temperature Range $(10-200^{\circ}K)$

A logical first attempt to fit the mobility in this temperature region is a simple, reciprocal addition of the extrapolated mobilities at high and at low temperatures. However, this procedure gives rise to values that are too high at all temperatures between 10 and 200°K and at 100°K by as much as a factor of 10. It seems that one or several, more effective, scattering mechanisms determine the mobility in the intermediate range. Yet, down to 90 or 100°K, there is very little spread in mobilities of samples of quite different electron concentration. Hence one should first explore intrinsic scattering processes. The third LO branch of the phonon spectrum ($\hbar\omega_{l_3}=0.022$ eV) has a very small coupling constant $[\alpha(m/m^*)^{1/2}=0.01]$ according to Eagles³¹]. Consequently, its contribution to optical mode scattering is negligible. Another possibility is collisions with the acoustical modes. In this case one would expect a slight step in the mobility at the 110°K phase transition, because the elastic constants show a discontinuity of several percent at this temperature.³² However, careful and precise measurements of conductivity and Hall effect around 110°K have revealed no trace of a discontinuity.

One could consider scattering by the lowest transverse optical mode,¹⁰ the "soft" mode.¹¹ Arguments against such a process have been listed in the introduction of this paper.

We have explored all the intrinsic scattering mechanisms treated in the literature. Unfortunately, it has not produced a satisfactory explanation for the magnitude of the mobility in the intermediate-temperature range.

CONCLUSION

The Hall mobility μ_H of electrons in SrTiO₃ has been investigated between 1 and 1000°K. Above 300°K the temperature dependence and the magnitude indicate that longitudinal optical mode scattering is the limiting process. Order-of-magnitude agreement between theoretical predictions and experimental data implies that ionized impurity scattering is probably the major factor determining the mobility at very low temperatures (1-10°K). An evaluation of μ_H using a cross section proportional to a_F^2 (where a_F = Fermi-Thomas screening radius) yields values that are 2 to 3 times *smaller* than the experimental data for Nb- or La- doped specimens. This underestimation occurs in spite of the surprisingly small size of a_F (1.4 to 2.5 Å).

In comparing the theoretical and the measured values of the mobilities, it should be emphasized that both at high and at very low temperatures the *absolute* magnitude has been calculated without the use of any adjustable parameters.

At intermediate temperatures $(10-200^{\circ}K)$, another so far unknown collision process appears to contribute to the electron scattering.

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³¹ The value 0.001 for $\alpha(m/m^*)^{1/2}$ in Ref. 19 is a misprint; it should read $\alpha(m/m^*)^{1/2} = 0.01$. D. M. Eagles (private communication).

³² R. O. Bell and G. Rupprecht, Phys. Rev. 129, 90 (1963).